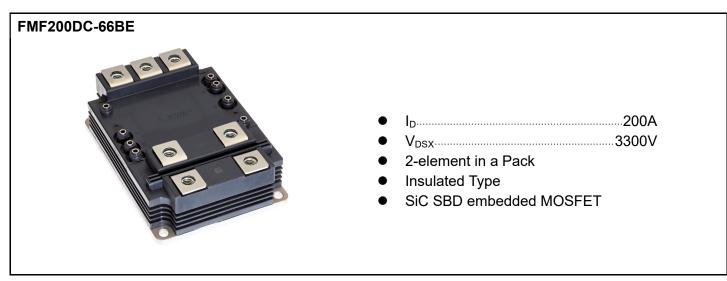


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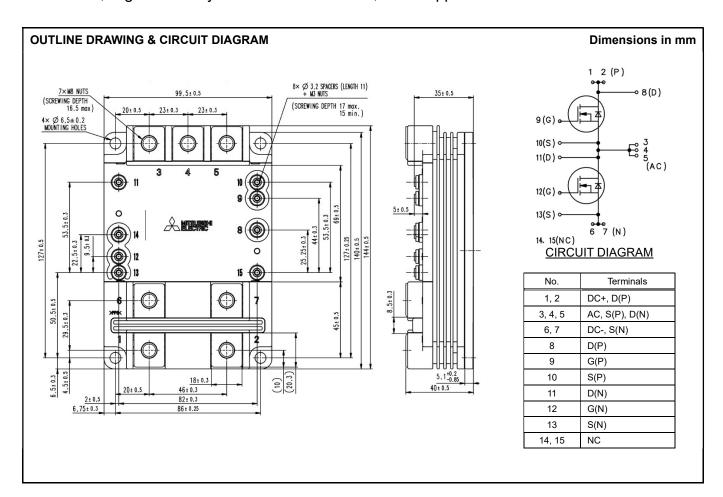
HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



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MAXIMUM RATINGS

Item	Symbol	Condition			Unit
Drain-Source voltage, specified gate-source voltage	V _{DSX}	V _{GS} = -7 V	3300	٧	
Gate-Source voltage	V _{GSS}	$V_{DS} = 0 \text{ V}$ $T_j = -40 \sim 175 ^{\circ}\text{C}$			V
Drain current	I _D	V_{GS} = 17 V , T_c = 105 $^{\circ}$ C , AC terminal output current (Note 1)	•	200	Α
Drain current	I _{DP}	Non repetitive pulse	$T_j = T_{op}$	400	Α
Reverse drain current (FWD forward current)	Is	$V_{\rm GS}$ = -7 V , $T_{\rm c}$ = 103 °C , AC terminal output current(Note 1)(No	te 2)	200	Α
Reverse drain current (FWD forward current)	I _{SP}	Non repetitive pulse(Note 2) $T_j = T_{op}$			Α
Total power dissipation	P _{tot}	T _c = 25 °C , MOSFET part(Note 3)	2080	W	
Isolation voltage	V _{isol}	Charge part to the baseplate RMS sinusoidal. 60Hz 1min			Vrms
Partial discharge charge	Q_{pd}	Charged part to the baseplate RMS sinusoidal, 60 Hz 1min V1 = 3500 V, V2 = 2600 V(acc. to IEC 61287-1)			pC
Junction temperature	Tj	Maximum temperature range in off-state or on-state(non-switching	-40~175	°C	
Case temperature	T _c	Maximum case temperature range in on-state			°C
Storage temperature	T _{stg}	Maximum case temperature range in off-state			°C
Operating junction temperature	T _{jop}	Maximum junction temperature range for switching operation			°C
Short-circuit withstand pulse duration	t _{pSC}	$V_{DD} = 2500 \; V \; , \; V_{GS} = +17 \; / \; -7 \; V \; , \; L_s = 40 \; nH \; , \; V_{GS}50\% - V_{GS}50\% \qquad T_j = T_{op}$		1.7	μs
Short circuit energy	E _{SC}	$V_{DD} = 2500 \text{ V}$, F(t)weibull=1% $T_j = T_{op}$			J
Non-repetitive surge forward current	I _{FSM}	t_0 = 10ms, F(t)weibull=1%, Half sinewave T_1 = 175 °C			kA
I2t value	l ² t	t_p = 10ms, $F(t)$ weibull=1%, Half sinewave T_j = 175 °C			kA ² s

ELECTRICAL CHARACTERISTICS

Item	Symbol			Limits			Unit
TICHT	Оупрог			Min.	Тур.	Max.	Offic
Gate-source leakage current	I _{GSS}	$V_{DS} = 0 \text{ V}$, $V_{GS} = V_{GSS}$	T _j = 25 °C	-0.5	-	0.5	μΑ
			$T_j = 25 ^{\circ}\text{C}$	-	0.8	-	μA
Drain-source cut-off current	I _{DSX}	$V_{DS} = V_{DSX}$, $V_{GS} = -7 V$	$T_j = 150 ^{\circ}C$	-	12.5	-	μA
			T _j = 175 °C	-	20.0	750	μA
			$T_j = 25 ^{\circ}\text{C}$	1.60	2.10	2.60	V
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = 10 \text{ V}$, $I_{D} = 20 \text{mA}$	$T_j = 150 ^{\circ}\text{C}$	-	1.50	-	V
			T _j = 175 °C	0.90	1.45	1.90	V
		$V_{DS} = V_{DS(on)}$, $V_{GS} = 17 V$	$T_j = 25 ^{\circ}\text{C}$	-	8.00	-	mΩ
Drain-source on resistance	r _{DS(on)}		$T_j = 150 ^{\circ}\text{C}$	-	17.25	-	mΩ
			T _j = 175 °C	-	20.00	24.25	mΩ
Drain-source on-state voltage		I _D = 200 A , V _{GS} = 17 V (Note 4)	$T_j = 25 ^{\circ}\text{C}$	-	1.60	-	V
	$V_{DS(on)}$		T _j = 150 °C	-	3.45	-	V
			T _j = 175 °C	-	4.00	4.85	V
		I _S = 200 A , V _{GS} = 17 V (Note 4)	T _j = 25 °C	-	1.45	-	V
Source-drain voltage	$V_{SD(on)}$		T _j = 150 °C	-	3.25	-	V
			T _j = 175 °C	-	3.80	4.40	V
		I _S = 200 A , V _{GS} = 0 V (Note 4)	$T_j = 25 ^{\circ}C$	-	2.00	-	V
Source-drain voltage	V_{SD}		T _j = 150 °C	-	3.85	-	V
			T _j = 175 °C	-	4.35	5.00	V
		I _S = 200 A , V _{GS} = -7 V (Note 4)	T _j = 25 °C	-	2.00	-	V
Source-drain voltage	$V_{SD(off)}$		T _j = 150 °C	-	3.85	-	V
			T _j = 175 °C	-	4.35	5.00	V
Input capacitance	C _{iss}	V_{DS} = 10 V , V_{GS} = 0 V , f = 100kHz , 1/2 module	T _j = 25 °C	-	27.6	-	nF
Output capacitance	Coss	V_{DS} = 10 V , V_{GS} = 0 V , f = 100kHz , 1/2 module	T _j = 25 °C	-	17.6	-	nF
Reverse transfer capacitance	C _{rss}	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 100 \text{kHz}$, $1/2 \text{ module}$	T _j = 25 °C	-	0.7	-	nF
Gate charge	Q _G	V_{DD} = 1800 V , I_D = 200 A , V_{GS} = +17 / -7 V , 1/2 module	T _j = 25 °C	-	0.8	-	μC

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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

ELECTRICAL CHARACTERISTICS

Item	Symbol	Conditions			Unit		
Item	Symbol	Conditions	Conditions			Max.	Offic
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 1800 \text{ V}$, $I_{D} = 200 \text{ A}$, $V_{GS} = +17 \text{ / -7 V}$, $L_{s} = 40 \text{ nH}$	T _j = 175 °C	-	-	0.37	μs
Rise time	t _r	$V_{DD} = 1800 \text{ V}$, $I_{D} = 200 \text{ A}$, $V_{GS} = +17 \text{ / -7 V}$, $L_{s} = 40 \text{ nH}$	T _j = 175 °C	-	-	0.23	μs
Turn on (quitabing) anargy		$V_{DD} = 1800 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _j = 25 °C	-	0.07	-	J
Turn-on (switching) energy per pulse 10% integral	E _{on(10%)}	$R_{G(on)} = 1.5 \Omega$, $R_{G(off)} = 6.0 \Omega$, Inductive load	T _j = 150 °C	-	0.06	-	J
per palse 1070 magrai		1 (G(on) = 1.3 12 , 1 (G(off) = 0.0 12, 11 (due tive load	T _j = 175 °C	-	0.06	-	J
		$V_{DD} = 1800 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _j = 25 °C	-	0.07	-	J
Turn-on (switching) energy per pulse	Eon	$R_{G(on)} = 1.5 \Omega$, $R_{G(off)} = 6.0 \Omega$, Inductive load	T _j = 150 °C	-	0.06	-	J
		R _{G(on)} = 1.5 12 , R _{G(off)} = 0.0 12, Inductive load	T _j = 175 °C	-	0.06	-	J
		$V_{DD}=1800~V~,~I_D=200~A~,~V_{GS}=+17~/~-7~V~,~L_s=40~nH$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=6.0~\Omega,~Inductive~load$	T _j = 25 °C	-	2.7	-	μC
Total capacitive charge	$Q_{\mathbb{C}}$		T _j = 150 °C	-	3.1	-	μC
			T _j = 175 °C	-	3.1	-	μC
	E _{off_Diode(10%)}	$V_{DD}=1800~V~,~I_D=200~A~,~V_{GS}=+17~/~-7~V~,~L_s=40~nH$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=6.0~\Omega,~Inductive~load$	T _j = 25 °C	-	0.24	-	mJ
Diode turn-off energy (per pulse)			T _j = 150 °C	-	-	-	mJ
			T _j = 175 °C	-	0.54	-	mJ
	E _{off_Diode}	$V_{DD}=1800~V~,~I_D=200~A~,~V_{GS}=+17~/~-7~V~,~L_s=40~nH$ $R_{G(on)}=1.5~\Omega~,~R_{G(off)}=6.0~\Omega,~Inductive~load$	T _j = 25 °C	-	0.34	-	mJ
Diode switching off energy of diode			T _j = 150 °C	-	-	-	mJ
			T _j = 175 °C	-	0.65	-	mJ
Turn-off delay time	t _{d(off)}	$V_{DD} = 1800 \text{ V}$, $I_{D} = 200 \text{ A}$, $V_{GS} = +17 \text{ / -7 V}$, $L_{s} = 40 \text{ nH}$	T _j = 175 °C	-	-	0.94	μs
Fall time	t _f	$V_{DD} = 1800 \text{ V}$, $I_{D} = 200 \text{ A}$, $V_{GS} = +17 \text{ / -7 V}$, $L_{s} = 40 \text{ nH}$	T _j = 175 °C	-	-	0.40	μs
Turn off (qwitching) aparay	E _{off(10%)}	V_{DD} = 1800 V , I_D = 200 A , V_{GS} = +17 / -7 V , L_s = 40 nH $R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 Ω, Inductive load	T _j = 25 °C	-	0.03	-	J
Turn-off (switching) energy per pulse 10% integral			T _j = 150 °C	-	0.03	-	J
			T _j = 175 °C	-	0.03	-	J
	E _{off}	V = 4000 V 1 = 000 A V = 147 / 7 V 1 = 40 mH	T _j = 25 °C	-	0.03	-	J
Turn-off (switching) energy per pulse		$V_{DD} = 1800 \text{ V}$, $I_D = 200 \text{ A}$, $V_{GS} = +17 / -7 \text{ V}$, $L_s = 40 \text{ nH}$	T _j = 150 °C	-	0.03	-	J
		$R_{G(on)}$ = 1.5 Ω , $R_{G(off)}$ = 6.0 Ω , Inductive load	T _j = 175 °C	-	0.03	-	J

THERMAL CHARACTERISTICS

Item	Cumbal	Symbol Conditions -		Limits		
item	Symbol			Тур.	Max.	Unit
Thermal resistance junction to case	R _{th(j-c)}	Junction to Case, MOSFET + embeded SBD part, 1/2 module	-	-	72.0	K/kW
Contact thermal resistance case to heatsink	R _{th(c-s)}	Case to heat sink, λ_{grease} = 1W/m·K, $D_{(c-s)}$ = 70 μ m, 1/2 module	-	57.0	-	K/kW

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HIGH POWER SWITCHING USE

INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

MECHANICAL CHARACTERISTICS

Item Sym	C) made al	Canditions		Unit		
	Symbol	Conditions		Тур.	Max.	Ullit
Mounting torque	Mt	fain terminal screw M8 his is the case when installing the product on the bus bar		-	22.0	N∙m
Mounting torque	Mt	Mounting screw M6	3.0	-	6.0	N∙m
Mounting torque	Mt	Auxiliary terminals screw M3	0.4	-	0.8	N∙m
mass	m	-	-	0.8	-	kg
Comparative tracking index	CTI	-	600	-	-	-
Clearance distance in air	da	Between main terminal	8.0	-	-	mm
Creepage distance along surface	ds	-	32.0	-	-	mm
	L _{PDS}	Between DC+ and DC-(terminal1,2-6,7)	-	28	-	nΗ
Internal inductance, D-S	L _{PDS}	Between DC+ and AC, (terminal1,2-3,4,5)	-	50	-	nΗ
	LPDS	Between AC and DC-(terminal3,4,5-6,7)	-	50	-	nН

Note 1. Control Case Temperature (T_C) so that the junction temperature (T_j) does not exceed the maximum rating.

Note 2. The symbols represent characteristics of the anti-parallel, source to drain free-wheel diode (FWDi).

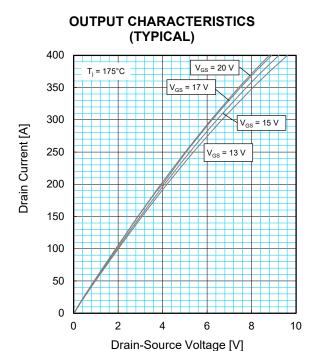
Note 3. Junction temperature (T_j) should not exceed T_{jmax} rating.

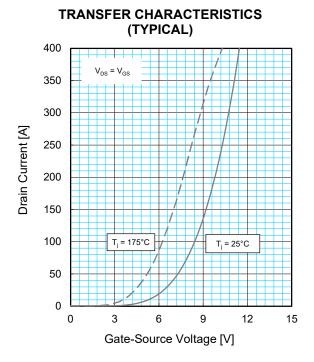
Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

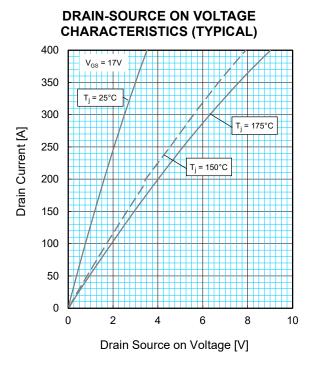
HIGH POWER SWITCHING USE

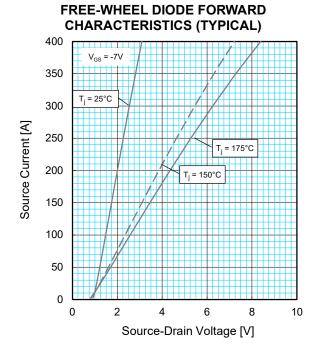
INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

PERFPRMANCE CURVES





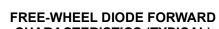


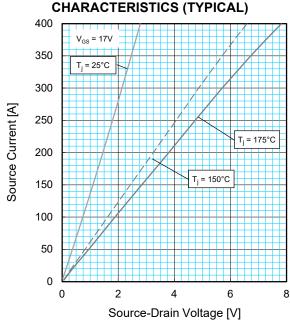


HIGH POWER SWITCHING USE

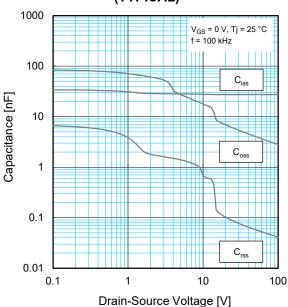
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PERFORMANCE CURVES

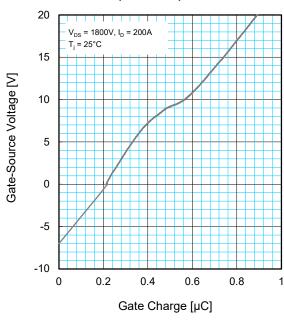




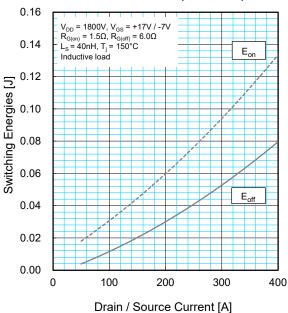
CAPACITANCE CHARACTERISTICS (TYPICAL)



GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)

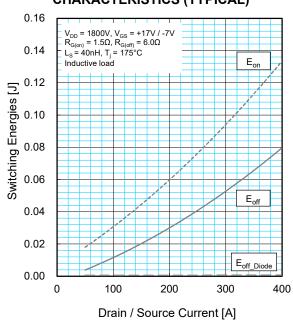


HIGH POWER SWITCHING USE

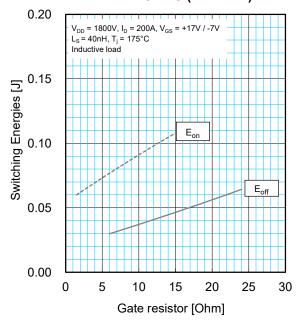
INSULATED TYPE 2nd gen. HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Modules

PERFORMANCE CURVES

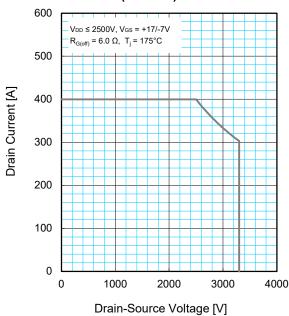
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



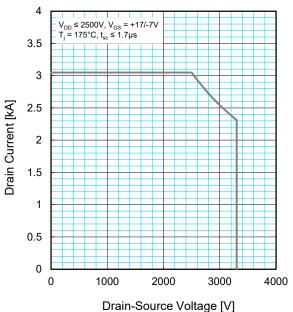
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



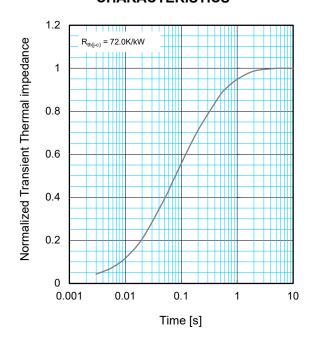
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HIGH POWER SWITCHING USE

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PERFORMANCE CURVES

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

	1	2	3	4
R _i /R _{th} :	0.0078	0.1975	0.3553	0.4393
τ _i [sec.] :	0.0001	0.7324	0.0381	0.1698

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